# MOSFET – Power, N-Channel, SOT-223 3.0 A, 60 V

Designed for low voltage, high speed switching applications in power supplies, converters and power motor controls and bridge circuits

#### **Features**

- NVF Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **Applications**

- Power Supplies
- Converters
- Power Motor Controls
- Bridge Circuits

#### MAXIMUM RATINGS (T<sub>C</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V <sub>DSS</sub>	60	Vdc
Drain-to-Gate Voltage (R <sub>GS</sub> = 10 MΩ)	$V_{DGR}$	60	Vdc
Gate-to-Source Voltage - Continuous - Non-repetitive (t <sub>p</sub> ≤ 10 ms)	V <sub>GS</sub>	± 20 ± 30	Vdc Vpk
$ \begin{array}{ll} Drain \ Current \\ - \ Continuous @\ T_A = 25^{\circ}C \\ - \ Continuous @\ T_A = 100^{\circ}C \\ - \ Single \ Pulse \ (t_p \leq 10 \ \mu s) \end{array} $	I <sub>D</sub> I <sub>D</sub> I <sub>DM</sub>	3.0 1.4 9.0	Adc Apk
Total Power Dissipation @ T <sub>A</sub> = 25°C (Note 1)  Total Power Dissipation @ T <sub>A</sub> = 25°C (Note 2)  Derate above 25°C	P <sub>D</sub>	2.1 1.3 0.014	W W W/°C
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 25^{\circ}\text{C}$ ( $V_{DD} = 25 \text{ Vdc}, V_{GS} = 10 \text{ Vdc},$ $I_L(\text{pk}) = 7.0 \text{ Apk}, L = 3.0 \text{ mH}, V_{DS} = 60 \text{ Vdc})$	E <sub>AS</sub>	74	mJ
Thermal Resistance  - Junction-to-Ambient (Note 1)  - Junction-to-Ambient (Note 2)	$R_{ heta JA} \ R_{ heta JA}$	72.3 114	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	ç

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. When surface mounted to an FR4 board using 1" pad size, 1 oz. (Cu. Area 1.127 sq in).
- 2. When surface mounted to an FR4 board using minimum recommended pad size, 2-2.4 oz. (Cu. Area 0.272 sq in).

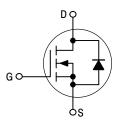


## ON Semiconductor®

www.onsemi.com

3.0 A, 60 V  $R_{DS(on)} = 110 \text{ m}\Omega$ 

N-Channel







AWW
3055

1 2 3
Gate Drain Source

= Assembly Location

WW = Work Week

STYLE 3

3055 = Specific Device Code = Pb-Free Package

(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTF3055-100T1G	SOT-223 (Pb-Free)	1000 / Tape & Reel
NTF3055-100T3G	SOT-223 (Pb-Free)	4000 / Tape & Reel
NVF3055-100T1G	SOT-223 (Pb-Free)	1000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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## **ELECTRICAL CHARACTERISTICS** (T<sub>A</sub> = 25°C unless otherwise noted)

Charac	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage $(V_{GS} = 0 \text{ Vdc}, I_D = 250 \mu\text{Adc})$ Temperature Coefficient (Positive)	V <sub>(BR)DSS</sub>	60 -	68 66	- -	Vdc mV/°C	
Zero Gate Voltage Drain Current (V <sub>DS</sub> = 60 Vdc, V <sub>GS</sub> = 0 Vdc) (V <sub>DS</sub> = 60 Vdc, V <sub>GS</sub> = 0 Vdc, T <sub>J</sub> = 150°C)		I <sub>DSS</sub>	- -	- -	1.0 10	μAdc
Gate-Body Leakage Current (V <sub>GS</sub> = ± 20 Vdc, V <sub>DS</sub> = 0 Vdc)		I <sub>GSS</sub>	-	-	± 100	nAdc
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage (Note 3) $(V_{DS} = V_{GS}, I_D = 250 \mu Adc)$ Threshold Temperature Coefficient (N	legative)	V <sub>GS(th)</sub>	2.0 -	3.0 6.6	4.0 -	Vdc mV/°C
Static Drain-to-Source On-Resistand (V <sub>GS</sub> = 10 Vdc, I <sub>D</sub> = 1.5 Adc)	R <sub>DS(on)</sub>	-	88	110	mΩ	
Static Drain-to-Source On-Resistant ( $V_{GS}$ = 10 Vdc, $I_D$ = 3.0 Adc) ( $V_{GS}$ = 10 Vdc, $I_D$ = 1.5 Adc, $T_J$ =	V <sub>DS(on)</sub>	-	0.27 0.24	0.40 -	Vdc	
Forward Transconductance (Note 3) (V <sub>DS</sub> = 8.0 Vdc, I <sub>D</sub> = 1.7 Adc)	9 <sub>fs</sub>	-	3.2	-	Mhos	
DYNAMIC CHARACTERISTICS		<u>.</u>				
Input Capacitance		C <sub>iss</sub>	_	324	455	pF
Output Capacitance	$(V_{DS} = 25 \text{ Vdc}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz})$	C <sub>oss</sub>	-	35	50	1
Transfer Capacitance	· ····=,	C <sub>rss</sub>	-	110	155	1
SWITCHING CHARACTERISTICS	S (Note 4)					
Turn-On Delay Time		t <sub>d(on)</sub>	-	9.4	20	ns
Rise Time	$(V_{DD} = 30 \text{ Vdc}, I_D = 3.0 \text{ Adc}, V_{GS} = 10 \text{ Vdc},$	t <sub>r</sub>	-	14	30	
Turn-Off Delay Time	$R_{GS} = 10 \text{ VdC},$ $R_{G} = 9.1 \Omega) \text{ (Note 3)}$	t <sub>d(off)</sub>	-	21	45	
Fall Time		t <sub>f</sub>	-	13	30	
Gate Charge	(V <sub>DS</sub> = 48 Vdc, I <sub>D</sub> = 3.0 Adc, V <sub>GS</sub> = 10 Vdc) (Note 3)	Q <sub>T</sub>	-	10.6	22	nC
		Q <sub>1</sub>	-	1.9	-	1
	, , , ,	Q <sub>2</sub>	-	4.2	_	
SOURCE-DRAIN DIODE CHARA	ACTERISTICS					
Forward On-Voltage	$(I_S = 3.0 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_S = 3.0 \text{ Adc}, V_{GS} = 0 \text{ Vdc},$ $T_J = 150^{\circ}\text{C}) \text{ (Note 3)}$	V <sub>SD</sub>	- -	0.89 0.74	1.0 -	Vdc
Reverse Recovery Time		t <sub>rr</sub>	-	30	-	ns
	(I <sub>S</sub> = 3.0 Adc, V <sub>GS</sub> = 0 Vdc,	ta	-	22	-	
$dI_S/dt = 100 \text{ A/µs}$ (Note 3)		t <sub>b</sub>	-	8.6	-	]
Reverse Recovery Stored Charge		Q <sub>RR</sub>	-	0.04	-	μC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0%.
 Switching characteristics are independent of operating junction temperatures.

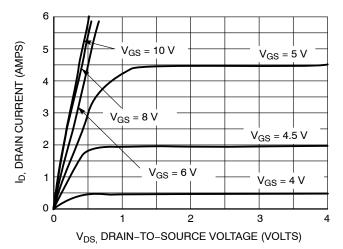


Figure 1. On-Region Characteristics

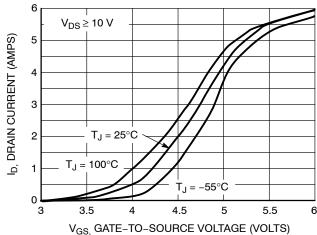


Figure 2. Transfer Characteristics

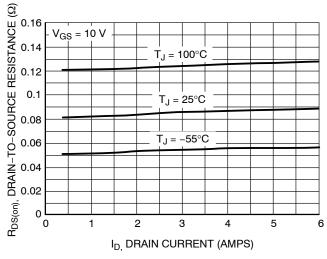


Figure 3. On-Resistance versus Gate-to-Source Voltage

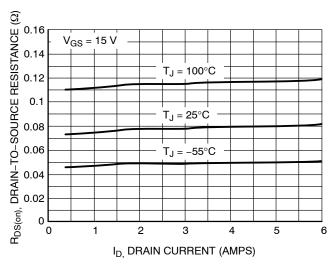
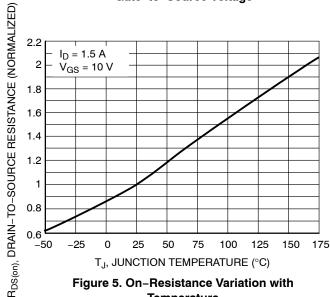


Figure 4. On-Resistance versus Drain Current and Gate Voltage



**Temperature** 

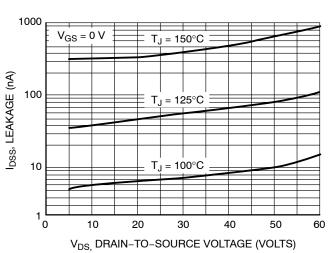


Figure 6. Drain-to-Source Leakage Current versus Voltage

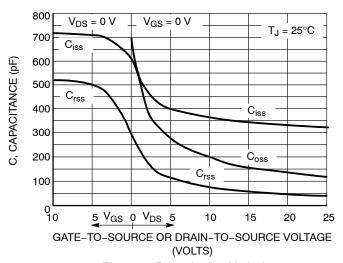


Figure 7. Capacitance Variation

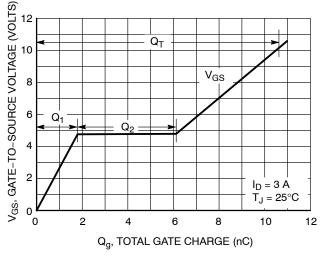


Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

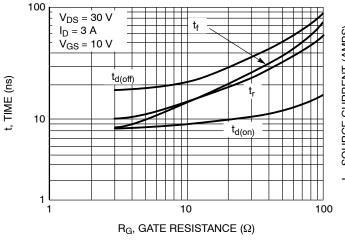


Figure 9. Resistive Switching Time Variation versus Gate Resistance

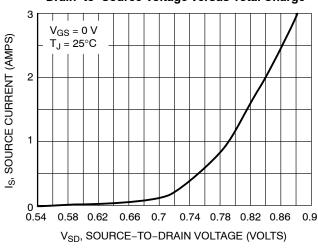


Figure 10. Diode Forward Voltage versus Current

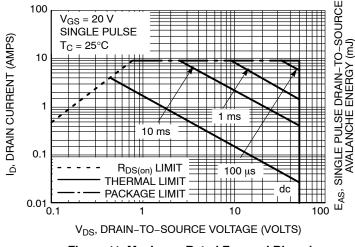


Figure 11. Maximum Rated Forward Biased Safe Operating Area

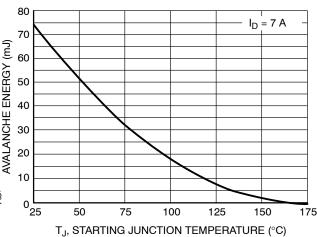


Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

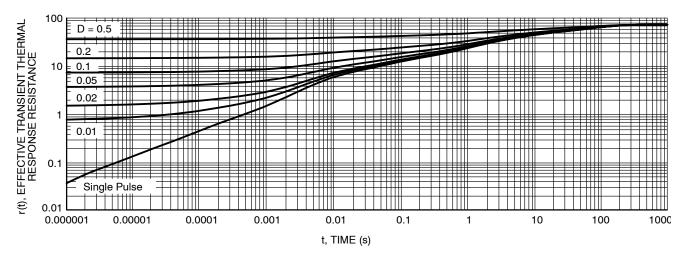
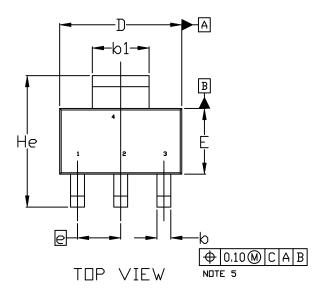


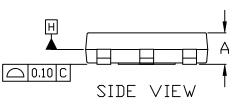
Figure 13. Thermal Response



SOT-223 (TO-261) CASE 318E-04 ISSUE R

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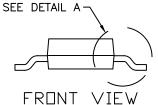




DETAIL A

A1-

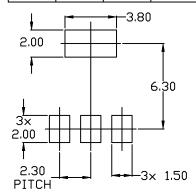






- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS D & E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.200MM PER SIDE.
- DATUMS A AND B ARE DETERMINED AT DATUM H.
- A1 IS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.
- POSITIONAL TOLERANCE APPLIES TO DIMENSIONS b AND b1.

	MILLIMETERS			
DIM	MIN.	N□M.	MAX.	
Α	1.50	1.63	1.75	
A1	0.02	0.06	0.10	
Ø	0.60	0.75	0.89	
b1	2.90	3.06	3.20	
U	0.24	0.29	0.35	
D	6.30	6.50	6.70	
E	3.30	3.50	3.70	
е	2.30 BSC			
L	0.20			
L1	1.50	1.75	2.00	
He	6.70	7.00	7.30	
θ	0°		10°	



RECOMMENDED MOUNTING **FOOTPRINT** 

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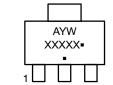
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**DATE 02 OCT 2018** 

STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR	STYLE 2: PIN 1. ANODE 2. CATHODE 3. NC 4. CATHODE	STYLE 3: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN	STYLE 4: PIN 1. SOURCE 2. DRAIN 3. GATE 4. DRAIN	STYLE 5: PIN 1. DRAIN 2. GATE 3. SOURCE 4. GATE
STYLE 6: PIN 1. RETURN 2. INPUT 3. OUTPUT 4. INPUT	STYLE 7: PIN 1. ANODE 1 2. CATHODE 3. ANODE 2 4. CATHODE	STYLE 8: CANCELLED	STYLE 9: PIN 1. INPUT 2. GROUND 3. LOGIC 4. GROUND	STYLE 10: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE
STYLE 11: PIN 1. MT 1 2. MT 2 3. GATE 4. MT 2	STYLE 12: PIN 1. INPUT 2. OUTPUT 3. NC 4. OUTPUT	STYLE 13: PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR		

# GENERIC MARKING DIAGRAM\*



A = Assembly Location

Y = Year W = Work Week

not follow the Generic Marking.

XXXXX = Specific Device Code

= Pb-Free Package

(Note: Microdot may be in either location)
\*This information is generic. Please refer to
device data sheet for actual part marking.
Pb-Free indicator, "G" or microdot "•", may
or may not be present. Some products may

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